Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/500,012	ONAKA, KAZUHIRO	
Examiner	Art Unit	
Jay M. Patidar	2862	

SEARCHED					
Class	Subclass	Date	Examiner		
324	252	7/19/2006	JP		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEAR((INCLUDING SE	CH NOTES EARCH STRATEGY	')
	DATE	EXMR
EAST searched. 324/2\$.ccls.	7/19/2006	JP
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